

Notice of References Cited	Application/Control No. 10/057,413	Applicant(s)/Patent Under Reexamination MARTIN ET AL.	
	Examiner Hai V. Nguyen	Art Unit 2142	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0111994	08-2002	Raghunandan, Hulikunta Prahlad	709/203
	B	US-2002/0052925	05-2002	Kim et al.	709/217
	C	US-2002/0038363	03-2002	MacLean, John M.	709/224
	D	US-6,857,024	02-2005	Chen et al.	709/231
	E	US-6,826,534	11-2004	Gupta et al.	705/1
	F	US-6,564,202	05-2003	Schuetze et al.	707/2
	G	US-6,493,702	12-2002	Adar et al.	707/3
	H	US-6,438,579	08-2002	Hosken, Benjamin E.	709/203
	I	US-6,183,366	02-2001	Goldberg et al.	463/42
	J	US-6,047,327	04-2000	Tso et al.	709/232
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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